

INSTRUCTION MANUAL

TR47242

Personality Kit

MANUAL NUMBER 47242 OEA 606

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PREFACE

PREFACE

This manual applies to the system disk P47242-001FJ V2.0.



RECORD OF REVISIONS

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LIST OF RELATED MANUALS

LIST OF RELATED MANUALS

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	TR4725 Logic Analyzer TR47250 Personality Kit TR47251 Personality Kit	
	TR47252 Personality Kit TR47241 Personality Kit	
	TR47242 Personality Kit TR47243 Personality Kit	



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1.1 HOW TO USE THIS INSTRUCTION MANUAL

1. GENERAL INFORMATION

1.1 HOW TO USE THIS INSTRUCTION MANUAL

The ADVANTEST TR4725 Logic Analyzer instruction manual consists of the TR4725 instruction manual (hereafter called the main unit instruction manual) and all of the personality kit instruction manuals (the PK instruction manual).

For beginners of logic analyzer, ADVANTEST recommends reading in the order of Chapter 1 and Chapter 2, Section 2.8 "Panel Descriptions" of the main unit instruction manual and then Chapters 1, 2 and 3 of the PK instruction manual for familiarization of the operating procedures (Chapters 2 and 3 of the main unit instruction manual are not necessary to read.).

1.2 TR47242 GENERAL DESCRIPTIONS

1.2 TR47242 GENERAL DESCRIPTIONS

The TR47242 8085 Personality Kit is the plug-in probe for state analysis used by installing in the TR4725 Logic Analyzer main unit. The major features of this personality kit are as follows:

- (1) State analysis has been expedited since 8085 mnemonic is also available, along with numeric values, for analysis of the captured data.
- (2) Data capturing is assigned to special hardware, thus high accuracy analysis can be performed with a smaller probe.
- (3) State analysis efficiency has been upgraded since symbols and codes are defined and provided for setting measuring conditions or analyzing measured data.
- (4) Complicated applications are enabled by more than one trace window condition and memory fragmentation for setting trace conditions.
- (5) Measurement labor-saving, standardization, and automation have been achieved by the application of high performance user interface, such as the use of the interactive menu procedure and the simple-to-use disk operation.
- (6) The major system software provided with the system disk attached to the personality kit ensures the upgrading of the performance functions along with the system disk updated revision.

1.3 UNPACKING AND INSPECTION

1.3 UNPACKING AND INSPECTION

1.3.1 Appearance Check and Component Confirmation

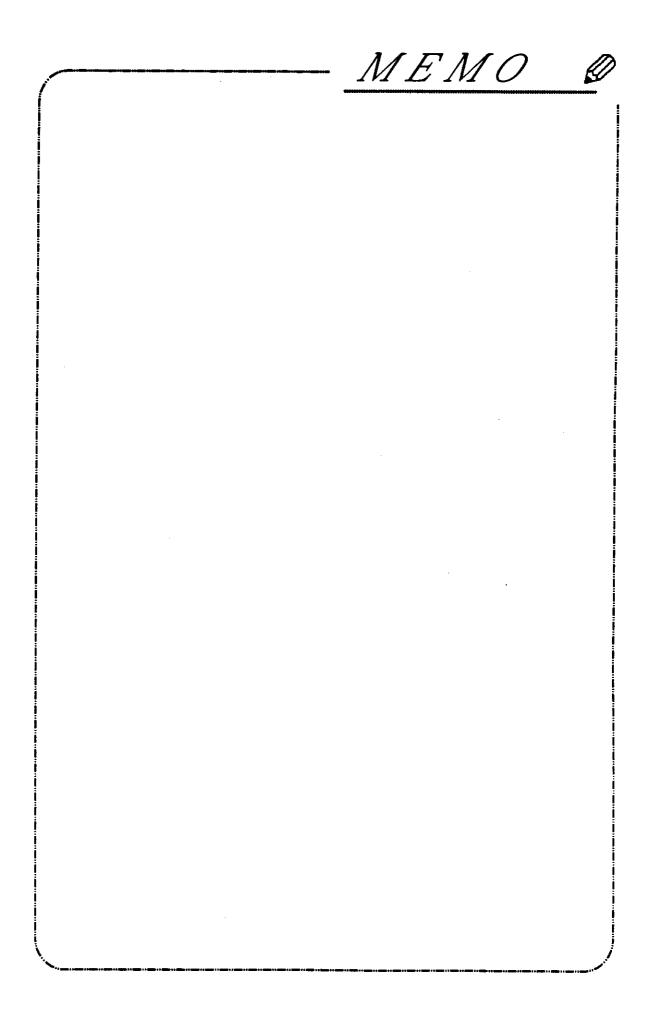
Upon receiving the TR47242 Personality Kit, inspect the product appearance to check for any damage caused by transportation.

Next, check the component quantity and ratings according to the following list. If any inadequacy or defect or damage is found, contact your nearest ADVANTEST representative. The addresses and telephone numbers are listed at the end of this manual.

Item name	Model name	Q'ty
Personality board		1
Microprocessor probe	TR14724-20	1
40-pin DIP clip cable	A04724-21	1
40-pin DIP plug cable	A04724-22	1
Probe test adapter		1
40-pin DIP IC package		1
System software package	P47242-001FJ	2
Blank disk	MF-2DD	2
Disk storage case		1
Miscellaneous container		1
Personality kit storage case		1
Instruction manual	E47242	1

^{*} The blank disk can be purchased separately.

Model name: A09502 (one set contains ten disks.)



2.1 INTRODUCTION

2. MEASUREMENT PREPARATION AND PREPARATORY INFORMATION

2.1 INTRODUCTION

Be sure to read this chapter if using this probe for the first time. This chapter describes the operations preparatory to measurement and the necessary preparatory information. The description is constructed so that the reader can understand the contents of it while actually operating the probe. Therefore, place the probe within reach when reading this manual for operation.

2.2 PERSONALITY BOARD INSTALLATION METHOD

2.2 PERSONALITY BOARD INSTALLATION METHOD

Follow the following procedures for installing the personality board. (The personality board is not installed in the TR4725 main unit when shipped.)

- (1) Check that the power is turned OFF.
- (2) Remove the four machine screws (3mm;+) from the main unit cover and remove the upper cover.
- (3) When an other personality board is already installed, remove it. Markers "1" and "2" are affixed on the personality board slot (refer to Figure 2-1).
- (4) Install the personality board with marker "1" on the board ejector into the slot "1". Then, connect the 50-pin flat cable to the connector in the center of the board.
- (5) Mount the four machine screws to re-set the upper cover.

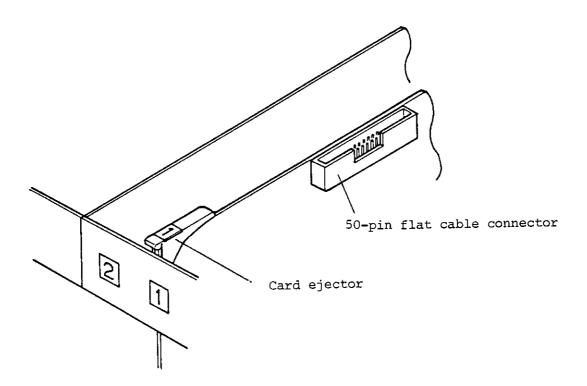


Figure 2-1 Personality Board Installation Method

2.3 CONNECTING PROBE AND THE SYSTEM UNDER TEST

2.3 CONNECTING PROBE AND THE SYSTEM UNDER TEST

Perform the following procedures to connect probe to the system to be measured using 8085:

2.3.1 Connecting Microprocessor Probe

This personality kit contains a microprocessor probe (TR14724-20) for connecting a system under test (termed SUT hereafter) in which a microprocessor 8085 is used. This section describes the actual connecting method of the probe. For how to handle the data captured by the probe, see Section 4.2.1.

Figure 2-2 shows the shape and parts names of the microprocessor probe.

(1) Connecting the microprocessor probe to the main unit

Two connectors with the name plates "C" and "D" are provided at the cable end of the microprocessor probe (TR14724-20). Insert respectively the two connectors to the probe slots in the main unit rear panel. The connectors can be locked by screws.

Before connecting microprocessor probe, make sure to turn OFF the power of the main unit.

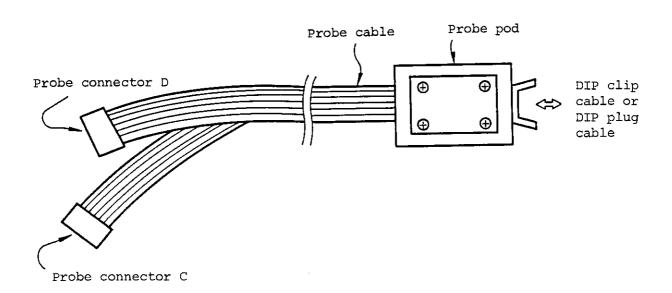


Figure 2-2 Microprocessor Probe Shape and Parts Names

2.3 CONNECTING PROBE AND THE SYSTEM UNDER TEST

(2) Connecting the microprocessor probe and SUT

There are two procedures to connect the microprocessor probe to the SUT (System Under Test): by using DIP clip cable or DIP plug cable. These are illustrated respectively in Figures 2-3 and 2-4.

Either procedure is applicable when the target microprocessor uses a socket. Only DIP clip cable is applicable when soldering is used for the target microprocessor. The connecting must be performed without mistaking pin 1 position no matter which procedure is adopted.

2.3 CONNECTING PROBE AND THE SYSTEM UNDER TEST

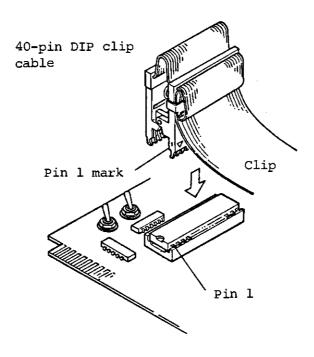


Figure 2-3 The Use of DIP Clip Cable

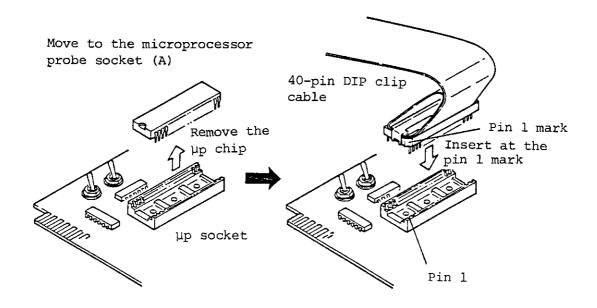
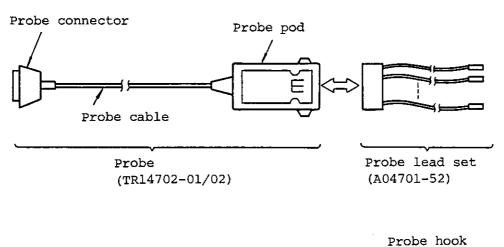


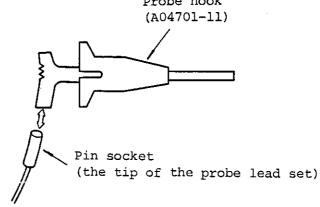
Figure 2-4 The Use of DIP Plug Cable

2.3 CONNECTING PROBE AND THE SYSTEM UNDER TEST

2.3.2 Connecting Data Acquisition Probe E/F

Two probes, data acquisition probe E (TR14702-01; hereafter called probe E) and data acquisition probe F (TR14702-02; hereafter called probe F), are used to capture data from the system under test (hereafter called SUT). Each probe can capture signals of eight channels. The shapes and parts names of probe E/F are shown in Figure 2-5.





indicates that the part can be freely attached and removed

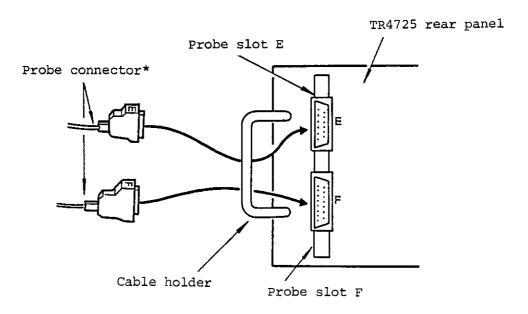
Figure 2-5 Probe E/F Shape and Parts Names (standard configuration)

2.3 CONNECTING PROBE AND THE SYSTEM UNDER TEST

First, connect the probe to the TR4725 main unit. Connect the probe E cable connector to the probe slot E ("E" is marked at the rear panel) and the probe F cable connector to the probe slot F after each probe connector is put through the cable holder at the left of the rear panel as shown in Figure 2-6.

___ CAUTION -

Before connecting probe E/F, make sure to turn OFF the power of the main unit.



*: Insert the connector name plate E/F upward

Figure 2-6 Connecting Probe E/F to the TR4725 Main Unit

Next, connect probe to SUT. As a standard procedure, use the probe lead set (A04701-52) with pin socket to connect probe to SUT via probe hook (A04701-11; single hook). When the pin which is suitable for pin socket is found in SUT, direct connection with the pin socket is possible. The stock No. and size of the pin socket is as follows:

2.3 CONNECTING PROBE AND THE SYSTEM UNDER TEST

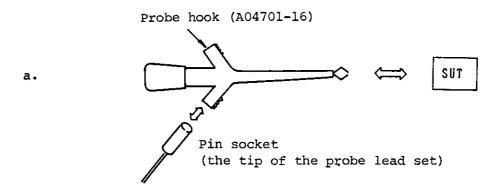
Manufacturer	Stock No.	Suitable size
AUGAT KK-JAPAN	LSG-2BG2-1	0.51mmø ~ 0.76mmø

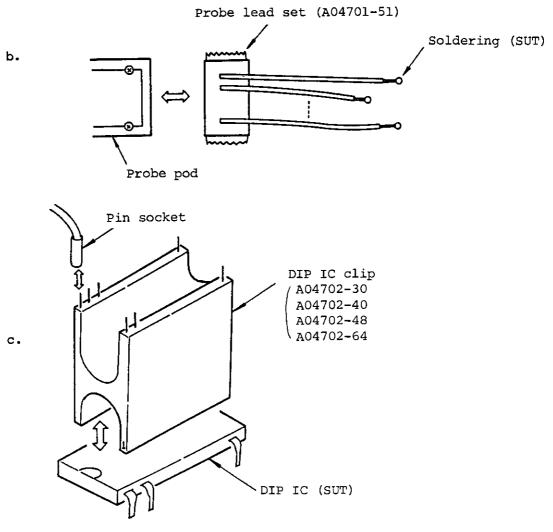
If necessary, probe can be connected to the SUT by using other optional accessories. Instead of the standard probe hook, the probe hook with a double hook tip-pin (A04701-16; double hook) can be used. (Refer to Figure 2-7 (a).)

Use the probe lead set (A04701-51) when soldering is used instead of probe hook or pin socket for connection. In this case, the connection of eight channels can be performed in one procedure. (Refer to Figure 2-7 (b).)

The use of the DIP IC clip (A04702-30/40/48/64) makes the connecting with DIP IC easier. In this case, connect the pin socket to the pin of the clip. (Refer to Figure 2-7 (c).)

2.3 CONNECTING PROBE AND THE SYSTEM UNDER TEST





*: Match at pin 1 and then clip.

Figure 2-7 Connecting SUT with Optional Accessories

2.4 USE OF THE MICROPROCESSOR PROBE

2.4 USE OF THE MICROPROCESSOR PROBE

(1) Use of the microprocessor probe socket

Insert the removed target microprocessor into socket on the probe and lower the lever when connecting probe and the SUT with the DIP plug cable.

(2) Use of the status LEDs on the microprocessor probe

The following six status LEDs can be found on the microprocessor probe monitoring the state of the SUT microprocessor: (Refer to the TR14724-20 External View at the end of this manual.)

- CLK : Lights when clock signal is applied.
 RESET : Lights when reset signal is applied.
 READY : Lights when ready signal is applied.
- TRAP : Lights when TRAP signal is applied.
- RST/INTR: Lights when RST7.5, RST6.5, RST5.5, or INTR signal is applied.
- HOLD : Lights when BUSRQ or HALT signal is applied.

2.5 LOADING THE SYSTEM SOFTWARE

2.5 LOADING THE SYSTEM SOFTWARE

The software (system software) which controls the operation of the personality kit is loaded from the system disk (P47242-001FJ) to the internal memory and executed. The built-in floppy disk drive is used for the system software loading.

Insert the system disk into the floppy disk drive, turn $\underline{\text{ON}}$ the $\underline{\text{POWER}}$ switch, and then loading starts automatically.

As shown in Figure 2-8, the following messages are displayed for loading:



System software loading in progress

Self-test ended

054725 U2.1 Copyright 1985 ADVANTEST CORPORATION

Figure 2-8 Screen Display for Loading

Loading requires approximately one minute. At the end of loading, CONFIGURATION (corresponds to CONFIG key) menu is displayed and the system enters into operation-enabled state as shown in Figure 2-9.

2.5 LOADING THE SYSTEM SOFTWARE

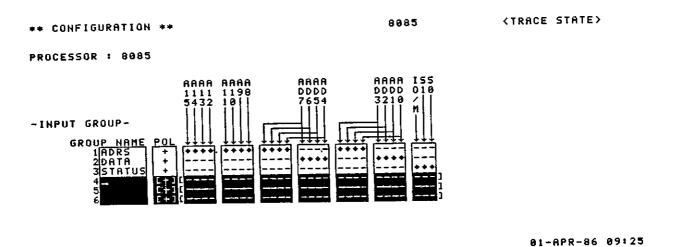


Figure 2-9 Screen Display at the End of Loading (CONFIG menu screen)

When the screen as shown in Figure 2-10 is displayed, it indicates that the internal clock is not functioning properly. Set the precise time by referring to Section 8.1 of the main unit instruction manual.

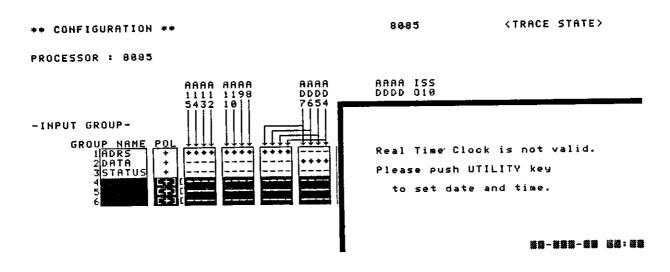


Figure 2-10 Screen Display Requesting Built-in Clock Setting

2.5 LOADING THE SYSTEM SOFTWARE

The display as shown in Figure 2-11 appears, requiring insertion of the system disk when the system disk is not inserted in the floppy disk drive when the <u>POWER</u> switch is turned <u>ON</u>. When the system disk is inserted, even when this display is shown, loading will start automatically. After the display of Figure 2-8, the display of either Figure 2-9 or Figure 2-10 appears and the system enters into operation-enabled state.



Please enter TR47242 8085 PK System Software Package !

Self-test ended

054725 U2.1 Copyright 1985 ADVANTEST CORPORATION

Figure 2-11 Screen Display Requesting System Disk Insertion

2.6 CRT DISPLAY FORMATS AND MEANINGS

[HEX] [HEX] [HEX]

One sample data file is stored in the system disk for the explanation from Sections 2.6 to 2.9. To better understand the operation, read the following descriptions while actually operating the personality kit. Press on the upper right of the front panel. Then, the menu display as shown in Figure 2-9 will appear (the same display as shown after the loading of the system software). The setting of the input channel configuration is enabled on the CONFIG menu screen. Press and the display as shown in Figure 2-12 will appear. The setting of the trace condition is enabled on the TRACE menu screen. ** TRACE SPECIFICATION ** ** TRACE SPECIFICATION ** ** TRACE STATE STORE! = TIEZE States DELAY = TREED

GROUP RADIX

ESTOP 1

XXXX

TRIG PASS = 301

 $\times \times$

01-APR-86 09:33

Figure 2-12 TRACE Menu Screen (TRACE SPECIFICATION)

TRIG OUT(SYNC) [OFF]

2.6 CRT DISPLAY FORMATS AND MEANINGS

Press and the display as shown in Figure 2-13 will appear. Analysis of the captured data is enabled on the DISPLAY menu screen.

** DISPLAY **

GROUP [HDRS] [DHT] [STHTUS] [HEX] [HEX] [HEX] [HEX] [HEX] [HEX] [HEX]

01-APR-86 09:34

Figure 2-13 DISPLAY Menu Screen

Basic measurement is executed in the State Only and S & T analyzers by interacting with the above three menu screens (configuration, trace specification, and display) and the menu screen by $\underline{\text{SYMDEF}}$ key (symbol definition).

Press on the lower center of the front panel twice. The file is read out and the data is displayed on the screen (refer to Figure 2-14).

** DIS	5PLAY **	from F811	DISP.REG		8085	5	KTRACE	STATE>	
GROUP RADIX		CHEX]	[STATUS] [HEX]	CHEX 3	CHEX,]	CHEX. 1	[HEX]	CHEX	
ล อิ อ อ อ	0000	F3			<u> </u>	·			
0001	0001	31	` 3						
0002	0002	98	2						
0003	0003	1 1	2						
0004	0004	FB	3						
0005	0005	C3	3						
0006	0006	40	2						
0007	0007	00	2						
0008	0040	ΕE	7						
0009	0040	FE	<u> </u>						
8810	0040	99	3						
0011	0041	01	3						
0012	0042	80	2						
9913	0043	10	2						
0014	0044	02	3						
0015	1080	12	<u>1</u>						
0016	0045	93	3						
		F0:D	ISP.REG,	gotten		+sor	oll 01-	APR-86	09:35

Figure 2-14 Sample Data for Explanation

2.6 CRT DISPLAY FORMATS AND MEANINGS

Each CRT display format contains a specific definition. The operation has been made easier by sustaining definition consistency through the whole displays.

(1) "Normal display": Usually displayed by characters or diagrams in green; used for displaying fixed information such as header word or measured data.

This indication is equivalent to headers such as DISPLAY on the upper left of the screen or measured data (list) in the above sample data.

- (2) "Inverse display": Indicates inversed luminance of the character or diagram. This is called "menu item". The user can use this to set or revise data. [HEX] is equivalent to this display in the above sample data.
- (3) "Normal blink display": Blinks to display "normal display"; used to display the status of the error message, measurement or I/O execution. By pressing any numeric key (for instance, 0) when the display as shown in Figure 2-14, the message called "normal blink display" is displayed on the bottom line of the CRT display.
- (4) "Inverse blink display": Blinks to display "Inverse display", indicates the "menu item" that can be currently entered. The blinking portion, in particular, is called "input prompt". The display format of [ADRS] immediately after GET is equivalent to this.
- (5) "Half-tone display": Indicates the half luminance which is used for measurement execution or I/O operation. The "input prompt" cannot be moved to the "menu item" which is turned to half-tone display (the setting of data to the menu item becomes disabled).
 - Press on the lower center of the front panel twice, and the display as shown in Figure 2-15 will appear. The menu display (e.g. main menu) other than the smaller menu display newly appearing on the CRT display (e.g. sub-menu) is called "half-tone display". Pay attention when referencing the display of figures since the "half-tone display" cannot be printed on the screen which is output by a video plotter (as shown in Figure 2-15).

2.6 CRT DISPLAY FORMATS AND MEANINGS

** DI	5PLAY **	from F0:0	ISP.REG		8985		KTRACE	STATE>
GROUP RADIX	CHEX 1	CHEX 1	[STATUS] [HEX]	CHEX 1	CHEX]	[HEX]	EHEX)	CHEX, I
100 100 100 100 100 100 100 100 100 100	0000 0001 00003 00004 00005 00006 0004 0004 0004 0004 0	F310118300185300186300188000188300018800018800018800018800018800018800001880000188000000	33223322773322313		** FD OPE OPERATION DRIVE F0:name_ DISP.REG	[DIRECT	DRY] of II attrida SP_S 01-	te

Figure 2-15 FD Menu Screen

2.7 INPUTTING DATA TO MENU ITEMS

2.7 INPUTTING DATA TO MENU ITEMS

The menu display corresponding to keys of $\underline{\text{MENU}}$ and $\underline{\text{I/O}}$ key groups can be displayed by pressing the key accordingly.

More than one menu items are presented on the menu display. The menu display corresponding to the $\underline{\text{MENU}}$ key group is called main menu display. The menu display corresponding to the $\underline{\text{I/O}}$ key group is called sub-menu display. The sub-menu display can be called or deleted at any time to the main menu display (when deleting, press any key of the MENU key group or

-). The main menu display becomes half-tone display when the sub-menu display is called. Try to enter keys to actually understand their functions. The four basic rules for inputting data to the menu items are as follows:
- The menu item for data inputting is displayed inversely.
- The menu item (input prompt) for inputting data (currently permitted) by pressing the ENTRY key is displayed by inverse blink display.
- (1) The menu item enclosed in brackets:

For the menu item enclosed in brackets, data is input by pressing SELECT
(with , many) key to select from the chain data group.

The data group is selected in due order with will key; in inverse order with key. Pay attention that the same menu item of the selectable data group can be different according to the ambient conditions. The

selection range of the data group can be referenced beforehand with (refer to item (1) of Section 2.6). No syntax error will occur with the data input by <u>SELECT</u> key, thus this method is adopted by the TR4725 as much as possible. The normal display enclosed in brackets are also menu items. However, data input is not allowed because of only one menu item selection. This inputting method is adopted for most of menu items is <u>DISPLAY</u> menu screen. Try to observe how the display can be changed for

the data group in the GROUP or RADIX menu item by pressing

2.7 INPUTTING DATA TO MENU ITEMS

(2) The menu items not enclosed in brackets:

For menu items that are not enclosed in brackets, data can be input by pressing any ENTRY keys other than the SELECT key. These menu items are designed for defining GROUP, SYMBOL, and CODE names (these are for the state analysis section only) or calling/storing file name and require numeric values of binary, octal, decimal, and hexadecimal. The initial character (or digit) of each menu item becomes the input prompt when the

input prompt item is moved by \(\begin{array}{c} \begin{

No explanation of the menu display of $\underline{\text{SYMDEF}}$ (not used for timing only analyzer) or $\underline{\text{PROGRAM}}$ key that execute a line of the menu items is given in this section.

2.8 USE OF HELP KEY

2.8 USE OF HELP KEY

assists the user by providing useful information for operating this personality kit. It has two functions: HELP (menu item) and HELP (key).

HELP (menu item) displays the data input related information (an active-type of information which changes with the measuring conditions) to each menu item. For the menu item which uses the SELECT key, the selectable data group when $\begin{bmatrix} max \\ max \end{bmatrix}$ / $\begin{bmatrix} max \\ max \end{bmatrix}$ is pressed is displayed.

HELP (key) displays the key-related information (a static-type of information which does not change with the measuring conditions) which includes basically the key function summary, the summary of the related key functions, and the index to the instruction manual. The operating method for each function differs.

(1) HELP (menu item) function

This function is available whenever the data input to the menu item is

possible (system disk is not necessarily required). When mer is pressed and then released, the HELP screen is displayed on the lower right or lower left of the CRT display avoiding the input prompt menu items. The examples are shown in Figures 2-16 and 2-17. The HELP screen can be deleted by pressing any key including the scroll knob. However, whichever key is pressed, its function remains valid (for instance: when the ENTRY key is pressed, data input is executed. Turning the scroll knob can delete HELP screen without affecting the main menu screen). Test the HELP function in DISPLAY menu screen.

2.8 USE OF HELP KEY

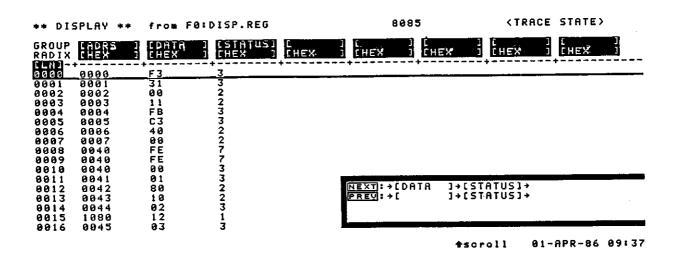


Figure 2-16 HELP (menu item) Function Display Example (1)

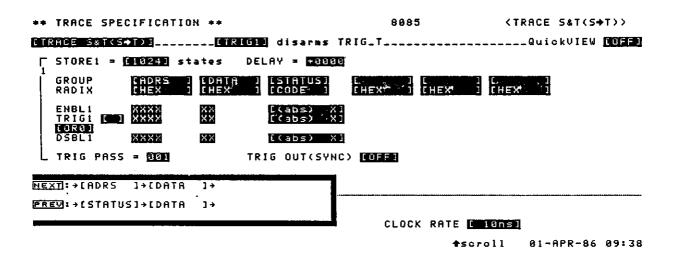


Figure 2-17 HELP (menu item) Function Display Example (2)

(2) HELP (key) function

This function is available only when the system disk is installed in the floppy disk drive and the system is under the key entry enabled state. The HELP screen is displayed on the right or the left side of the CRT

avoiding the menu item of the input prompt when with is pressed along with other desired function key. The display examples are shown in Figures 2-18 and 2-19.

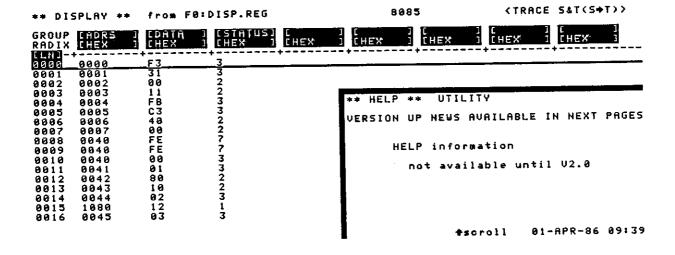


Figure 2-18 HELP (key) Function Display Example (1)

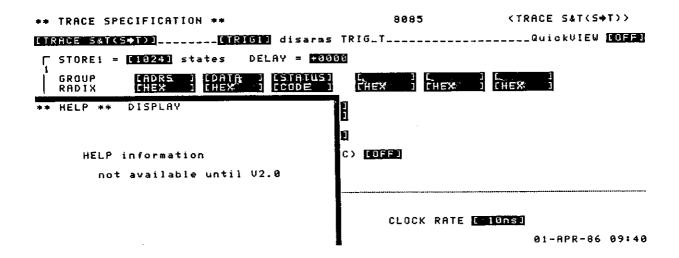


Figure 2-19 HELP (key) Function Display Example (2)

2.8 USE OF HELP KEY

When the scroll mark is displayed on the bottom line of the CRT, it indicates that the further data exist. The latest data can be displayed

by turning the scroll knob or pressing PAGE o o keys. Pressing any key, other than the scroll knob, can delete the HELP (key) screen. However, the EDIT and ENTRY keys can only be used to delete the screen, and the original key function becomes invalid.

The information displayed by the HELP (key) function and the currently displayed menu screen are not directly relates. Data is read and displayed from the system disk onto the HELP (key) screen, so the system disk must be installed in the floppy disk drive. When the system disk is not installed and this function is attempted to activate, the message as shown in Figure 2-20 is displayed. Test this function.

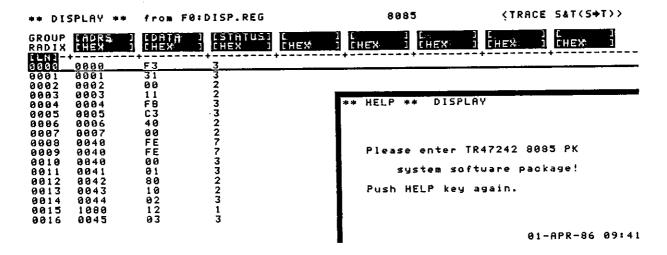


Figure 2-20 Screen Requesting System Disk Insertion by the HELP (key) Function

Screens are configured from combination of main menu, sub-menu, $\underline{\text{HELP}}$ (menu item), and $\underline{\text{HELP}}$ (key) screens and the attached screen other than the main

menu screen can be deleted completely by pressing [sip] .

2.9 USER DISK PREPARATION

2.9 USER DISK PREPARATION

The explanations of the previous sections are for actually operating the Personality Kit by its system disk, while this section deals with storing the measuring conditions, measured data, and programs on the user disk. The user disk is prepared by using the operation examples in Chapter 3. Disk formatting is required for preparing a user disk from a blank one. Remove the used system disk from the floppy disk drive and replace it with a blank disk.

Press and then four times, and the screen as shown in Figure 2-21 will appear.

** DI	SPLAY **	from F0:1	DÍSP.REG		8085	i	<trace< th=""><th>5&T(5→</th><th>·T>></th></trace<>	5&T(5 →	·T>>
GROUP RADIX	[HDRS] [HEX]	CHEX.]	(STATUS) (HEX)	CHEX]	CHEX 1	CHEX 1	CHEX]	CHEX.	
130 130 130 130 130 130 130 130 130 130	0000 0001 00003 00004 00005 00006 0004 0004 0004 0004 0	F310118300EE01001223	332233322773322313		** FD OPE OPERATION DRIVE DESCRIPT	[FORMAT		APR-86	99:42

Figure 2-21 Disk Format

Next, press twice to move the input prompt to the menu item "DESCRIPTION" and input characters of less than 20 character long (For

instance: "MY DISK"). Then, press [6]. The screen will ask "FORMAT?".

Press the green key on the bottom right corner of the front panel and then

to start formatting. When the screen as shown in Figure 2-22
 appears, it indicates the end of formatting. (The green key is the shift key, and "Y" is entered by the operations described above.)

2.9 USER DISK PREPARATION

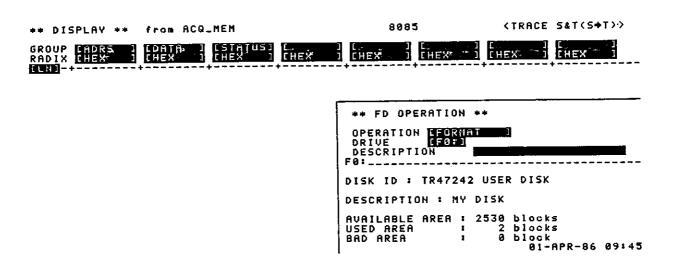
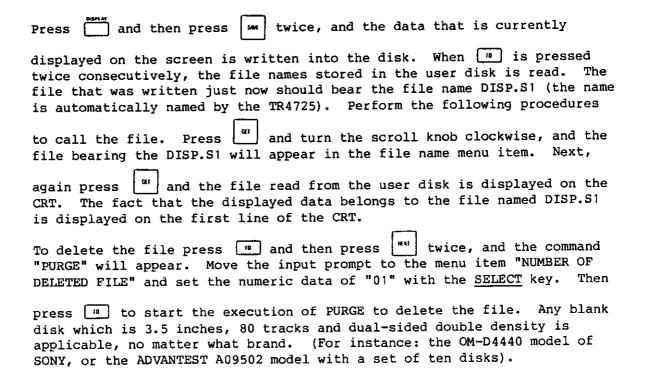


Figure 2-22 Display at the End of Disk Formatting



MEMO



3.1 INTRODUCTION

3. OPERATION EXAMPLES

3.1 INTRODUCTION

This chapter is to help beginners when learning how to operate the Personality Kit to gain a better understanding of the probe by providing some measuring examples.

The detailed operating procedures are described in the main unit instruction manual from Chapters 4 to 6, and Chapter 4 of the PK instruction manual. It is not necessary to read through all these manuals from the beginning. However, it is recommended to reference the important portions of them after learning the use of the probe from the following examples.

The operating procedures of the TR4725 are based on the operating rule of consistency, and thus can be operated by analogy. The following examples contain, along with the contents of Chapters 4 to 6 of the main unit instruction manual, the contents of the relations of the individual functions described in the PK instruction manual Chapter 4. Again, emphasis is on actual operation while reading the examples.

3.2 SIMPLE EXAMPLES OF TIMING ANALYSIS

3.2 SIMPLE EXAMPLES OF TIMING ANALYSIS

Connect probe E/F to the main unit (refer to Section 2.3.2) and load the system software (refer to Section 2.5).

The screen should display ** CONFIGURATION **. Then, press ____ to set the measuring mode to TRACE TIMING. Next, apply the suitable signal (TTL level is recommended) to the channel No. 7 of the probe F. Signal is displayed on the channel (label name: PRB_F7) on the upper most position as shown in Figure 3-1, if _mm is pressed. The sampling clock at this moment is 10 ns (100 MHz).

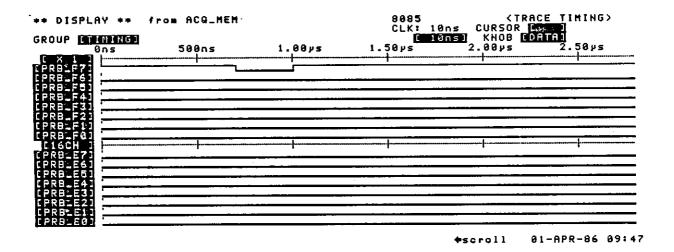


Figure 3-1 Timing Analysis Measurement Example (sampling clock: 10 ns)

Input signal changes will appear on the screen display. The sampling clock is changed by pressing after the input prompt is moved to the menu item of the sampling clock by pressing (try to set the sampling timing to 100 ns by pressing (mu) three times).

Next, press and the data will be displayed (as shown in Figure 3-2) in ten times the detail than what is shown in Figure 3-1.

3.2 SIMPLE EXAMPLES OF TIMING ANALYSIS

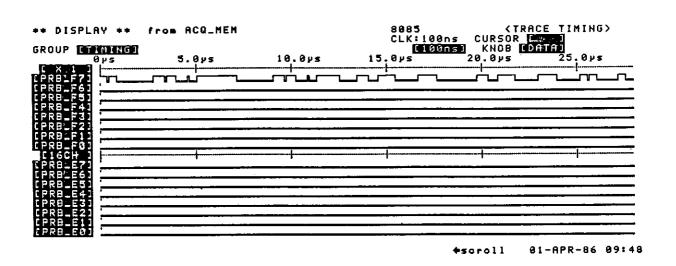


Figure 3-2 Timing Analysis Measurement Example (sampling clock: 100 ns)

What portion of the input signal starts to display is unpredictable no matter how many times [is pressed.

Turn the scroll knob clockwise to move the data on the screen to the left; and vice versa. Turn the scroll knob fast and the data moves fast; slow

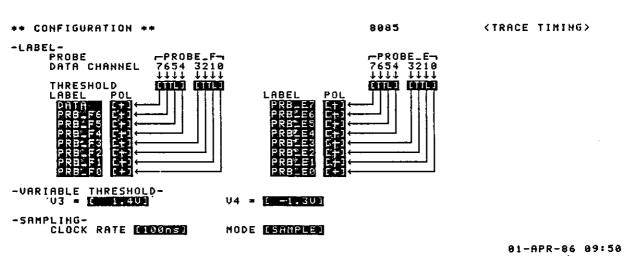
turning will also slow down the data changes. Next, press \bigcirc to move the input prompt to the menu item of [x 1] (time axis multiplier). The

time axis multiplier can be changed by pressing either or or expands the time axis; x 1/n contracts the time axis. All of the data contained in the memory (16 ch. x 2048 samples) attained at x 1/10 ratio is specified.

Next, press to move the input prompt to the menu item of [PRB_F7]. Enter "DATA" by using the character key of the ENTRY key group (refer to Figure 3-3).

Pay attention to the use of the shift key (the green key). When ____ is pressed following the previous procedures, the label name [PRB_F7] is changed and displayed as [DATA] as shown in Figure. This function ensures that the data analysis can be performed with great ease.

3.2 SIMPLE EXAMPLES OF TIMING ANALYSIS



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Figure 3-3 Label Name Definition Example

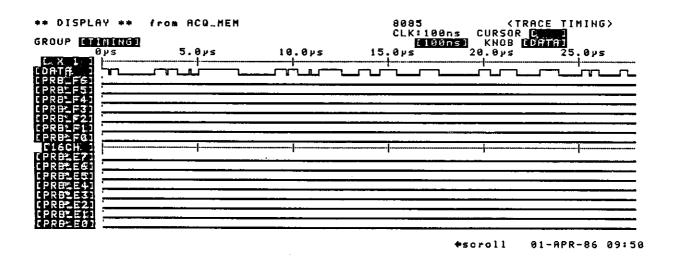


Figure 3-4 Label Name Usage Example

It is important to familiarize oneself with the operations and results on the DISPLAY screen by trying out all function keys related to the screen.

All of the operations on the <u>DISPLAY</u> screen are controlled by

meanings and the meaning of the menu item, Section 4.7.2 for the data scroll, Section 4.7.3 for cursor operation (two cursors of A and B can be used together), Section 4.7.4 for the time axis multiply and contraction, and Section 4.7.5 for the relations between the displayed data and the acquisition memory.

3.2 SIMPLE EXAMPLES OF TIMING ANALYSIS

Refer to Section 4.2.3 for the scr	reen that will appear next when is
pressed. Then, press $\stackrel{TMACE}{\square}$ and $\stackrel{C}{\square}$	to move the input prompt to TRIG_T.
Next, press i to set "1" to the	e equivalent position of "DATA" as shown
in Figure 3-5. When am is press	sed, the screen as shown in Figure 3-6
initial display remains at H level	er how many times man is pressed, the l. This means that action is triggered initial data). (On the time axis, 0 ns
	after setting 0 to "ENBL_T" and re 3-7. At this point, the trigger point
** TRACE SPECIFICATION **	8085 <trace timing=""></trace>
CTRACE TIMING 3	QuickVIEW MOTED
LABEL ENBL_T TRIG_T	CLOCK RATE [100ns]
DATA (PRB_F7) PRB_F6 (PRB_F6) PRB_F5 (PRB_F5) PRB_F4 (PRB_F3) PRB_F3 (PRB_F3) PRB_F3 (PRB_F2) PRB_F1 (PRB_F1) PRB_F6 (PRB_F0) PRB_E7 (PRB_E7) PRB_E8 (PRB_E5) PRB_E8 (PRB_E5) PRB_E9 (PRB_E5) PRB_E9 (PRB_E3) PRB_E9 (PRB_E3) PRB_E9 (PRB_E3) PRB_E9 (PRB_E1) PRB_E9 (PRB_E1) PRB_E9 (PRB_E1) PRB_E9 (PRB_E1)	DELAY = +0000 (0ps)
PRB_F4 (PRB_F4) X PRB_F3 (PRB_F3) X PRB_F2 (PRB_F2) X	
PRB_F1 (PRB_F1)	
PRB_E6 (PRB_E6)	
PRB_E4 (PRB_E4)	
PRB_E1 (PRB_E1)	
	01-APR-86 09:51

Figure 3-5 Trigger Pattern (TRIG__T) Setting Example

3.2 SIMPLE EXAMPLES OF TIMING ANALYSIS

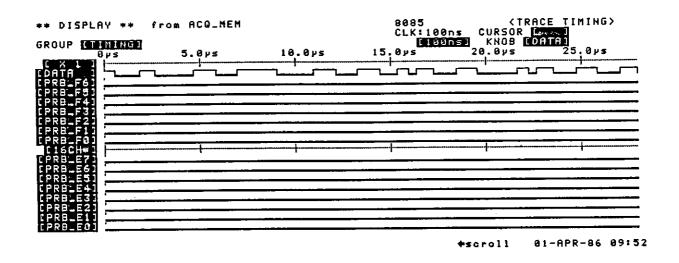


Figure 3-6 Measuring Example with Trigger Pattern Setting

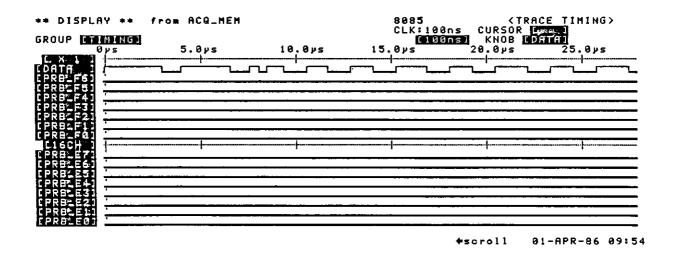


Figure 3-7 Delay Usage Example

Refer to Section 4.4.3 for the screen which appears when is pressed. When the above procedures are executed, the basic operation of the timing analysis outline can be grasped.

3.3 SIMPLE EXAMPLES OF STATE ANALYSIS

3.3 SIMPLE EXAMPLES OF STATE ANALYSIS

Connect the microprocessor probe to the main unit (refer to Section 2.3.1) and load the system software (refer to Section 2.5). Choose the desired processor when ** CONFIGURATION ** is displayed on the CRT. Next, press

[INCLETATE]

(immediately after POWER ON, the measuring mode turns into the TRACE STATE).

Then press [INCLETATE] and the measured data as shown in Figure 3-8 appears (the data differs according to the system measured).

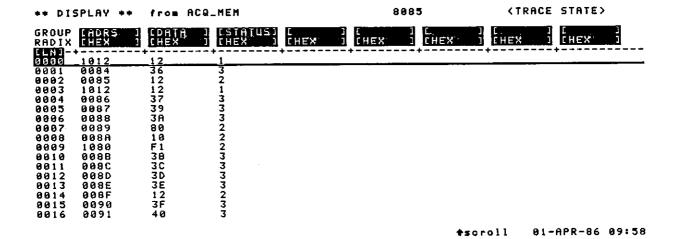


Figure 3-8 State Analysis Measuring Example

The input prompt is moved to the menu item of [ADRS] on the first line on the left. Check if the contents of GROUP is changed when pressed. ([ADRS] \rightarrow [DATA] \rightarrow [STATUS] \rightarrow [DATA])

Then, press to move the input prompt to the menu item [HEX] and check if the contents of RADIX is changed by pressing mail. Next, press to move the input prompt to the RADIX selection menu item of [DATA] (currently in [HEX]). [DATA] is displayed in 8085 mnemonic and [MNEM] with [S-by-S] is displayed on the when mail is pressed. Then press mail to display the program.

Then, try to turn the scroll knob. Turn the scroll knob clockwise to scroll the data upwards, and turn the knob counterclockwise to scroll the

data downwards. Next, press the PAGE [a] [b] keys. What the scroll knob can move by a line can be moved by these keys ten lines, vertically.

3.3 SIMPLE EXAMPLES OF STATE ANALYSIS

Familiarize yourself with these operations and their effects on the DISPLAY screen by trying out all the key functions. Refer to Section 4.6.2 of the main unit instruction manual for the display formats and their meanings and the meaning of the menu items, and Section 4.6.3 for the use of the reference memory.] and press 🗘 five times to move the input prompt to the Next, press menu item [ADRS] which is one element of TRIG1. Input here the pattern of one data in [ADRS] as shown in Figure 3-8. Then, press and the data with the pattern (called trigger) is moved to the upper most line of the measured data (refer to Figure 3-9). same pattern remains unchanged on the upper most line no matter how many times is pressed. Refer to Section 4.4.2 of the main unit instruction manual for the screen which appears when 8085 (TRACE STATE) ** DISPLAY ** from ACQ_MEM LSTATUS] THEX CHEX CHEX LDA 1080 9991 9991 9993 9994 9995 9996 9998 008A |22333332333333333 F1. 1988 9988 mem_rd SP 008C INR DCR 008E 008F 0090 0091 CMC 0009 0010 0011 0012 0013 0014 0015 B , B B , C MOV MOV 0093 0094 0095 MOV MOU 8 E B H MOU MOV B,L 0096 0097

Figure 3-9 Measuring Example by Trigger Pattern Setting (State Analysis)

The measured data can be displayed not just by numeric values but also names. (For instance: the function name used for program creation). Therefore, it is necessary to define names (SYMBOL and CODE names). The

display which appears by pressing is used for definition. For details, refer to Sections 4.3.2 and 4.3.3 of the main unit instruction manual.

When all of the above operations are executed, the outline of the basic operation of the state analysis can be understood.

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*scrol1

3.4 SIMPLE EXAMPLES OF S & T ANALYSIS

3.4	SIMPLE EXAMPLES OF S & T ANALYSIS
	Connect the microprocessor probe and probe E/F to the main unit and execute loading of the system software.
	Next, press $\[\]$ to set the measuring mode to TRACE S&T (S \rightarrow T) in which the state analysis and timing analysis sections operate simultaneously.
	Execution starts when is pressed. For the relations with the measured data, refer to Section 4.4.4 of the main unit instruction manual

3.5 FLOPPY DISK APPLICATIONS

3.5 FLOPPY DISK APPLICATIONS

When the main unit <u>POWER</u> switch is turned <u>OFF</u>, all of the measured data and data set in the menu item displayed on the screen described respectively in Sections 3.2 to 3.4 are deleted. For re-use of these data, it is very convenient to store them on the floppy disk. The operations of the disk file of the TR4725 differ from those of the general-purpose type computers such as personal computers, and are rather simple.

Refer to Section 4.2.4 of the main unit instruction manual for file
processing on the screen with, Section 4.3.4 for file processing on
the screen with \square , Section 4.4.5 for file processing on the screen with
, and Sections 4.6.4 and 4.7.5 for file processing on the screen with
OISPAAT •

3.6 USE OF QuickVIEW

3.6 USE OF QuickVIEW

The TR4725 has a new facility called QuickVIEW provided with the functions and ease of use of the oscilloscope for timing analysis.

The oscilloscope observes and measures the transitional condition of signals to be measured by setting the condition for attaining the desired screen and data by repeatedly operating the knobs of the trigger level or the key switches of time axis or input gain.

Though not exactly the same as the oscilloscope since the nature of the signals handled are different, QuickVIEW uses the scroll knob and provides the same ease of operation as the oscilloscope.

The operation procedures are simple. Press _____ to move the input prompt to the menu item of QuickVIEW and set [ON] with _____. Next, press _____ to enter into QuickVIEW mode. The sampling clock is changed by simply turning the scroll knob and then the real time data can be observed.

Refer to Section 4.8 of the main unit instruction manual for details of the QuickVIEW facility.

3.7 EXAMPLES OF USING THE PROGRAMS

3.7 EXAMPLES OF USING THE PROGRAMS

After the operations described in the previous sections are learned, it is easy to create the program of measurement procedures by simple programming.
Programming starts immediately when is pressed.
Programs can be created by simply pressing [MI], [MV], or []. The
command that can be selected by or has been made as similar as possible to the key operation. For instance, [TRACE] function is
equivalent to pressing . The created program is immediately
executable when www is consecutively pressed twice. Pressing
interrupts execution. For the operating procedures of the editor, refer to Section 6.2.1 of the main unit instruction Manual, and Section 6.2.2 for the type of commands that can be selected and their functions.

The created program is stored as a file (named as command file) and can be applied. For the application method, refer to Section 6.4 of the main unit instruction manual. Refer to Section 6.3 for the execution procedures of the command file.

The followings are explanations of some program examples. Try to create the same program for practice.

Figure 3-10 shows the program which executes the measurement by repetition (repeat function). The repeat function is a fixed function of conventional models of the logic analyzer. With the TR4725, all kinds of varieties can be developed. Figure 3-11 shows one example. The program as shown can display the acquired data within at five seconds most.

Run command is not necessarily required in the program. Figure 3-12 shows the program that only sets measuring conditions, which is convenient for setting measuring conditions to be used as a routine. Figure 3-13 shows the program that saves all kinds of measuring results in the system saved file after three measurements, by changing only the TRACE data. Figure 3-14 shows the program that repeats the measurement ten times under the same measuring conditions.

3.7 EXAMPLES OF USING THE PROGRAMS

			2225	/T00CE	TIMING>
** PROGRAM			8085 	CIRACECOMMENT	
92 (RUN1 91 (GOTO) 92 END				;	
				01-	-APR-86 10:04
	Figure 3-10	Repeat	Function Program	. 1	
** PROGRAM			86.85	<trace< td=""><td>TIMING></td></trace<>	TIMING>
00 [RUN] 01				;	

01-APR-86 10:05

Figure 3-11 Repeat Function Program 2

3.7 EXAMPLES OF USING THE PROGRAM

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Figure 3-12 Program That Only Sets Measuring Conditions

01-APR-86 10:12

Figure 3-13 Program Example -1

3.7 EXAMPLES OF USING THE PROGRAM

** PROGRAM **

LN__COMMAND

OO **

OO

01-APR-86 10:15

Figure 3-14 Program Example -2

MEMO



4.1 INTRODUCTION

4. PERSONALITY KIT PERFORMANCE CHARACTERISTICS

4.1 INTRODUCTION

The basic measurement operations are described in Chapter 4 of the main unit instruction manual. This chapter focuses on the performance characteristics of the Personality Kit. Refer to the related sections of the main unit instruction manual when reading this chapter. (For convenient reference, the section titles are identical.)

4.2 INPUT CHANNEL CONFIGURATION (CONFIG)

4.2 INPUT CHANNEL CONFIGURATION (CONFIG)

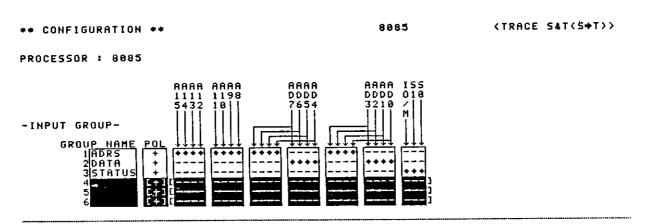
4.2.1 CONFIG Menu Screen for 8085 Microprocessor

The <u>CONFIG</u> function determines how to configure the TR4725 input block on which the personality kit is installed. Section 2.3.1 describes the physical connection between the probe and SUT. This section describes the <u>CONFIG</u> function that determines how the analyzer performs level conversion of the electric signal input from the probes for sampling operation, and how it converts that signal into easy-to-handle logical data.

The $\underline{\text{CONFIG}}$ menu screen is divided into three types by measurement mode. (The measurement mode is set at the $\underline{\text{TRACE}}$ menu screen. For details, see Section 4.2.1 of the main unit instruction manual.

The timing analysis menu screen is independent of the personality kit. For how to handle the timing analyzer, refer to Section 4.2.3 of the main unit instruction manual.

The state analysis menu screen is presented in Figure 4-1. The codes marked with the arrow sign stand for the name of the signal pins in 8085.



#scrol1 01-APR-86 10:16

Figure 4-1 CONFIG Menu Screen

4.2 INPUT CHANNEL CONFIGURATION (CONFIG)

The following item can be set at this menu screen:

- PROCESSOR: Indicates that this personality kit corresponds to the 8085 microprocessor. (fixed)
- POL : Specifies the polarization for signal capturing with + (positive) or - (negative).
- : Defines the unit in which several input channels are GROUP handled, as the input GROUP (termed GROUP hereafter). To define GROUP, specify the GROUP name having a maximum of six alphanumeric characters. Next, specify the input channel which belongs to the $\underline{\mathsf{GROUP}}$ by entering the ♠ mark. Up to six GROUPs can generally be defined. However, three of them, [ADRS], [DATA] and [STATUS] have already been defined in the personality kit, and therefore, the user cannot change the names of those groups. The remaining three groups can be defined by the user. The input channel which has already been used may also be overlapped. The number (called a GROUP number, for instance, 1 for the GROUP number of GROUP [ADRS]) in the left side of the GROUP name is used to specify the GROUP name to be compared during program execution of the command [DEFINE] or [COMPARE_RANGE]. (See Section 4.1.2 in the main unit instruction manual.)

The <u>PROCESSOR</u> name is always displayed in the center of the 1st line on the other menu screens. The defined <u>GROUP</u> may be used in the <u>TRACE</u> and <u>DISPLAY</u> menu screens.

4.3 SYMBOL AND CODE DEFINITIONS (SYMDEF)

4.3 SYMBOL AND CODE DEFINITIONS (SYMDEF)

This personality kit uses not only numeric values but also <u>SYMBOL</u> and <u>CODE</u> to set the trace condition (TRACE function) and to display and analyze the measured data (DISPLAY function). These are defined by the <u>SYMDEF</u> function.

SYMBOL is applicable to a GROUP having any number of channels. SYMBOL gives one SYMBOL name to numeric strings in a certain range. When used in accordance with the label or function name for program development, this SYMBOL improves the debugging efficiency.

CODE is applicable to a GROUP having 8 or fewer channels. It gives one CODE name to one numeric value, and therefore, the user can easily create the code tables.

For details ot the SYMBOL and CODE definitions, see Section 4.3 in the main unit instruction manual.

4.3.1 CODE Table for 8085

This personality kit has already been defined in the $\underline{\text{CODE}}$ tables for the $\underline{\text{GROUP}}$ [STATUS] (see Figure 4-2).

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Figure 4-2 Defined CODE Table (8085 status)

4.4 DISPLAY OF CAPTURED DATA IN STATE ANALYZER (DISPLAY)

4.4 DISPLAY OF CAPTURED DATA IN STATE ANALYZER (DISPLAY)

Figure 4-3 shows the measured data captured by the TR47242. For display format and menu screen setting, refer to Section 4.6.2 of the main unit instruction manual.

** DI	5PLAY **	from ACQ	_MEM		8085		KTRACE	STATE>	
GROUP RADIX	[ADRS]	CDAJA 1	CHEX 1	CHEX 1	[: THEX: :]	[HEX:]	CHEX. 13	[HEX	
0000	0003	11	2 3	•		· ·	•		
0001	0004	FB	3						
0002	8005	C3	3						
0003	0006	40	2						
8004	0007	9 8	2						
<u> </u>	0040	00	_3						
0006	0041	01	3						
0007	0042	80	2						
0008	0843	10	2						
8889	0044	82	3						
0010	1080	98	1						
0011	0045	03	3						
0012	0046	04	3						
0013	0047	0 5	3 .						
0014	0048	96							
0015	0049	12	2 3						
0016	904A	07	3						
						tsor	011 01-	APR-86	10:19

Figure 4-3 Measured Data Display Example

4.4.1 Measured Data Display

Figure 4-4 shows an example in which the data captured with the QUEUE sample mode is displayed in mnenonic. This data is the same data as given in Figure 4-3.

The part of ".." in the DATA displayed in mnemonic is defined as a part of the instruction code. In this case, the data for the ".." section is contained in the mnemomic (or operand) which is immediately above that ".." section. "." represents one haxadecimal digit data.

4.4 DISPLAY OF CAPTURED DATA IN STATE ANALYZER (DISPLAY)

** DISPLAY **	from ACQ_MEM	8085	<trace state=""></trace>
GROUP [ADRS] RADIX [HEX]	[DATA] [MNEM]with[S-by-S]	CODE 1 CHEX 1	[HEX] [HEX:] [HEX:]
0001 0004 0001 0004 0002 0005 0003 0006 0004 0007 0005 0040	11/mem_rd EI JMP 0040	MEM_RD OP OP MEM_RD MEM_RD OP	
0005 0006 0007 0007 0008 0009 0014 0010 0011 0045 0012 0046 0013 0047 0014 0048 0015 0049 0016 0048	STAX B 08/mem_ur INX B INR B DCR B MUI B,12 RLC	OP MEM_RD MEM_RD OP MEM_WR OP OP OP OP OP	
			#scroll 01-APR-86 10:20

Figure 4-4 S-by-S Display Example for Measured Data

The method for properly displaying the data which is captured by the analyzer is called the S-by-S (State-by-State) display mode. A mode excluding useless ".." sections in analysis operation from the above mode is called the PACKED display mode. Figure 4-4 shows the former display example, and Figure 4-5 shows the PACKED display by using the same data to be used in Figure 4-4.

** D19	SPLAY **	from ACQ_MEM	8085	<trace st<="" th=""><th>ATE></th></trace>	ATE>
GROUP RADIX	HEX 1	CONTA] CMNEM: Juith[PACKED]	CCODE 1 CHEX*	CHEX: 1 CHEX: 3	CHEX, I
0000	0003	11/mem_rd	MEM_RD	•	•
0001	9994	ΕI	0P		
0002	0005	JMP 0040	OP .		
0005	0040	NOP	OP		
0006	0041	LXI B,1080	OP	•	
0009	0044	STAX B	OP .		
0010	1080	08/mem_ur	MEM_WR		
0011	0045	INX B	GP		
0012	0046	INR B	OP		
0013	0047	DCR B	OP		
0014	0048	MVI B,12	OP		
0016	004A	RLC	0P		
9917	004B	DAD B	0P		
0018	004C	LDAX B	0.P		
0019	1281	10/mem_rd	MEM_RD		
0028	904D	DCX B	OP		
0021	004E	INR C	0P		
				#scroll 01-APF	R-86 10:21

Figure 4-5 PACKED Display Example for Measured Data

4.4 DISPLAY OF CAPTURED DATA IN STATE ANALYZER (DISPLAY)

4.4.2 8085 Disassembling Format

- (1) The mnemonic for the opcodes using Intel's 8085 standard assembly formats.
- (2) All the numerics used in operands are displayed in hexadecimal numbers. Accordingly, no codes for indicating the numeric base are used.
- (3) When GROUP [ADRS] is displayed by <u>SYMBOL</u>, its address as an operand is displayed by <u>SYMBOL</u> as much as possible. The display formats are: SYMBOL name + hhhh (h stands for one hexadecimal digit) SYMBOL name - hhhh
- (4) "/illegal" is displayed when any illegal or noninstallation instruction is detected.

MEMO



5.1 MICROPROCESSOR PROBE TEST

5. OPERATION CHECK

5.1 MICROPROCESSOR PROBE TEST

Since the Personality Kit uses connectors with many pins and cables for measurement, trouble such as imperfect contact occurs due to incorrect operation. A simple test is therefore designed to check the signal system operation. Perform the following procedures to check operation:

- (1) Mount the supplemented 8085 probe test adapter on the PROBE TEST connector in the TR4725 rear panel.
- (2) When a DIP plug cable is used, directly connect the microprocessor probe to the probe test adapter via a 40-pin DIP IC package. (Refer to Figure 5-1.)

5.1 MICROPROCESSOR PROBE TEST

TR4725 rear panel connector

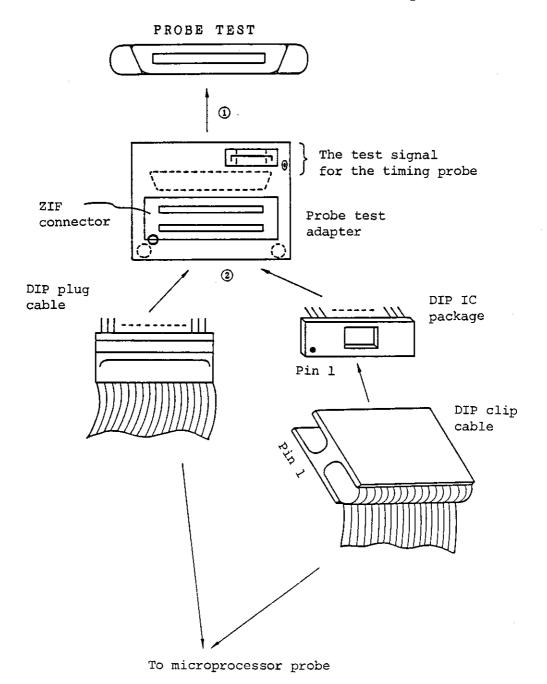


Figure 5-1 Probe Test Connection

5.1 MICROPROCESSOR PROBE TEST

- (3) Set to the TRACE menu screen. Next, press
- (4) Press to start checking.
- (5) Check if the display is the same as Figure 5-2; if it is, the operation is normal.

** DIS	SPLAY **	from ACQ.	.MEM		8085	5	(TRACE	STATE
GROUP RADIX		[DATA] [HEX]	CSTATUS] CHEX]	CHEX :	CHEX 1	[HEX]	EHEX 1	HEX:
9990	9099	00	2			•		
0001	1111	11	2	•				
0002	2222	22	2					
9903	3333	33	2					
9004	4444	44	i					
0095	5555	55	1					
6006	6666	66	1					
0007	7777	77	1					
9998	8888	88	6					
0009	9999	99	6					
9019	RARA	AA	6					
9011	B888	88	6					
9912	CCCC	CC	5					
0013	DDDQ	DD	5					
0014	EEEE	EE	5 5.					
0015	FFFF	F F	5.					
9169	0000	99	2					

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Figure 5-2 Microprocessor Probe Test Result

5.2 DATA ACQUISITION PROBE E/F TEST

5.2 DATA ACQUISITION PROBE E/F TEST

The signal (500 kHz, TTL level pulse) testing the probe E/F outputs on the probe test adapter as shown in Figure 5-1. Perform the following procedures for testing:

- (1) Connect the probe test adapter to the PROBE TEST connector on the TR4725 rear panel.
- (2) Connect all the parts of the probe E/F input channel that needs to be tested to the test signal terminal via probe hooks.
- (3) Set the measuring mode to TRACE TIMING on the TRACE menu screen and then set the clock rate to 100 ns after pressing
- (4) Press to start testing.
- (5) Check if the operation is normal by confirming that the display is the same as Figure 5-3. When error occurs with the measured data, contact your nearest ADVANTEST representative.

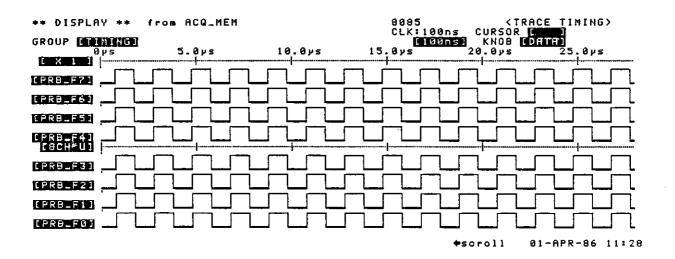


Figure 5-3 Probe E/F Test Result

6.1 STORAGE

6. EQUIPMENT STORAGE AND TRANSPORTATION PRECAUTIONS

6.1 STORAGE

The storage environment condition for the TR47242 Personality Kit is $-10^{\rm O}{\rm C}$ to $+60^{\rm O}{\rm C}$. When the probe is not used for a long time, place the kit in the Personality Kit storage case and keep in a dry place away from direct sunlight in particular, keep the board in the supplied conductive case). Be sure to store the floppy disk in an environment conditions of $+10^{\rm O}{\rm C}$ to $+60^{\rm O}{\rm C}$ (it is recommended to store the floppy disk separately from the Personality Kit storage case).

6.2 TRANSPORTATION

6.2 TRANSPORTATION

Use the packaging materials of first shipping when transporting the equipment. However, when the original packaging materials cannot be found, pack the equipment as follows:

- (1) Wrap the equipment with vinyl covers.
- (2) Wrap the equipment with 50 mm thick cushioning material and then place the wrapped equipment into a carton more than 5 mm thick.
- (3) After the equipment is wrapped with the cushioning material, put in the accessories, and then more cushioning material. Close the carton box and tie the box with packing ropes.

7.1 TR47242 SPECIFICATIONS

7. SPECIFICATIONS

7.1 TR47242 SPECIFICATIONS

Input Specifications

Applicable Microprocessor: 8085A, 8085AH (3 MHz), 8085A-2, 8085AH-2

(3 MHz), 8085AH-1 (6 MHz) of INTEL Co., or

their equivalents.

Microprocessor clock frequency

: Depends on the system to be measured.

Input current

: -200 µA max. (low level) 20 μA max. (high level)

Microprocessor status display

: The LED on the microprocessor probe displays

the status of CLK, RESET, READY, TRAP,

RST/INTR, and HOLD.

Logical polarity

: + or -

: Defined by the data input channel groups Input group

Input group name Input group number : An alphanumeric no more than 6 characters long

: 6 max. among which 3 are already defined (ADRS,

DATA, and STATUS)

Display Specifications

Display data source

: Acquisition memory, reference memory, and file

Display items

: 8 items max.

Input group display order: Capable of display by selecting the input group name in random order, repeated display ovf the same input group, and deletion of the specific

input group display.

Display format

: State can be displayed in binary, octal, decimal, hexadecimal, symbol, code, ASCII code, 8085 mnemonic (data only). S-by-S or PACKED

display in mnemonic notation.

7.1 TR47242 SPECIFICATIONS

Transmission between memories

: The displayed data is transmitted to the reference memory. Data in reference memory and

acquisition memory are displayed.

Data scroll

: Vertical scrolling by scroll knob. Page scroll key enables vertical scrolling in page units.

Specific display

: Trigger display for triggers. A memory boundary is displayed between trace windows.

Personality Kit configuration:

Item name	Model name	Q'ty	Remarks
Personality board		1	
Microprocessor probe	TR14724-20	1	
40-pin DIP clip cable	A04724-21	1	
40-pin DIP plug cable	A04724-22	1	
Probe test adapter		1	
40-pin DIP IC package		1	
System software package	P47254-001FJ	2	
Blank disk	MF-2DD	2	
Disk storage case		11	
Miscellaneous container		1	
Personality key storage case		1	
Instruction manual	E47242	1	

^{*} The blank disk can be purchased separately.

Model name: A09502 (one set contains ten disks.)

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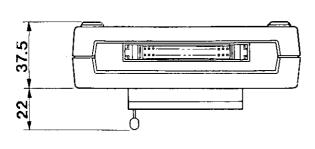


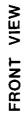
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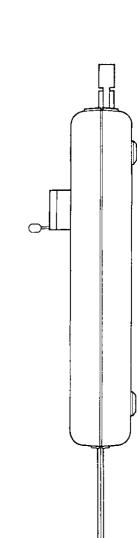
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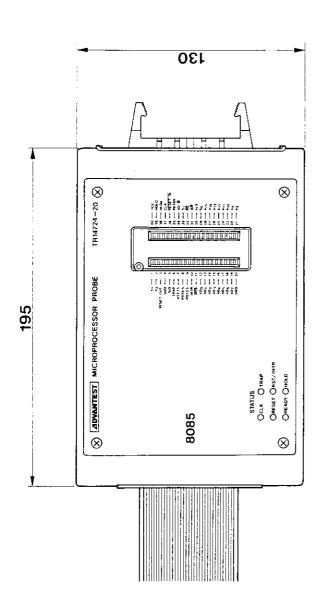








TOP VIEW



14724-20 EXTI-509-A

SIDE VIEW

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